## Notice of References Cited Application/Control No. Applicant(s)/Patent Under Reexamination HUANG, WEN-YUNG Examiner Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0120009 A1	06-2004	White et al.	358/001.18
	В	US-			
	C	US-			
	D	US-			
	Е	US-			
	ш	US-			
	G	US-			
	I	US-			
	1	US-			
	J	US-			
	K	US-			
	٦	US-	•		
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04337964 A	11-1992	Japan	FUJI, ATSUSHI	
	0					
	Р					
	Q	,				
	R					
	S					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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